

High mobility field-effect transistors based on MoS₂ crystals grown by the flux method

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Abstract

Two-dimensional (2D) molybdenum disulphide (MoS₂) transition metal dichalcogenides (TMDs) have great potential for use in optical and electronic device applications; however, the performance of MoS₂ is limited by its crystal quality, which serves as a measure of the defects and grain boundaries in the grown material. Therefore, the high-quality growth of MoS₂ crystals continues to be a critical issue. In this context, we propose the formation of high-quality MoS₂ crystals via the flux method. The resulting electrical properties demonstrate the significant impact of crystal morphology on the performance of MoS₂ field-effect transistors. MoS₂ made with a relatively higher concentration of sulphur (a molar ratio of 2.2) and at a cooling rate of 2.5 °C h⁻¹ yielded good quality and optimally sized crystals. The room-temperature and low-temperature (77 K) electrical transport properties of MoS₂ field-effect transistors (FETs) were studied in detail, with and without the use of a hexagonal boron nitride (h-BN) dielectric to address the mobility degradation issue due to scattering at the SiO₂/2D

material interface. A maximum field-effect mobility of 113 cm² V⁻¹ s⁻¹ was achieved at 77 K for the MoS₂/h-BN FET following high-quality crystal formation by the flux method. Our results confirm the achievement of large-scale high-quality crystal growth with reduced defect density using the flux method and are key to achieving higher mobility in MoS₂ FET devices in parallel with commercially accessible MoS₂ crystals.

Atomically thin forms of layered materials, such as conducting graphene, insulating hexagonal boron nitride (hBN), and semiconducting molybdenum disulfide (MoS₂), have generated great interests recently due to the possibility of combining diverse atomic layers by mechanical "stacking" to create novel materials and devices. In this work, we demonstrate field-effect transistors (FETs) with MoS₂ channels, hBN dielectric, and graphene gate electrodes. These devices show field-effect mobilities of up to 45 cm²/Vs and operating gate voltage below 10 V, with greatly reduced hysteresis. Taking advantage of the mechanical strength and flexibility of these materials, we demonstrate integration onto a polymer substrate to create flexible and transparent FETs that show unchanged performance up to 1.5% strain. These heterostructure devices consisting of ultrathin two-dimensional (2D) materials open up a new route toward high-performance flexible and transparent electronics.